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FJ		9061647	3/7/97		,	Japan			_		Abstract
		9080681	3/28/97			Japan		1			Abstract
		8069083	3/12/96	•	/	Japan					Abstract
		6267071	9/22/94		/	Japan					Abstract
FS		5301873	11/16/93		/	Japan		_	_	-	Abstract
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ks.		Bell, Scott I., "Metalation and Alkylation of 3,6-Dihydrothiazine 1-Oxides Prepared via Diels - Adler Cycloadditions of N-Sulfinyl Dienophils", J. Org. Chem. 1991, 56, 373-377.									
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Ks		Irie, Masahiro, "Diarylethenes for Memories and Switches", Chem. Rev. 2000, 100, 1685- 1716.									
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FORM PTO 1449 (modified)					ATTY DOCKET NO. 2589.600			APPLICATION NO. 09/892,655		
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		9077767	3/25/97		∠ Japan				Abstract	
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Es		9072585	3/18/97		Japan			<u>-</u>	Abstract	
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